

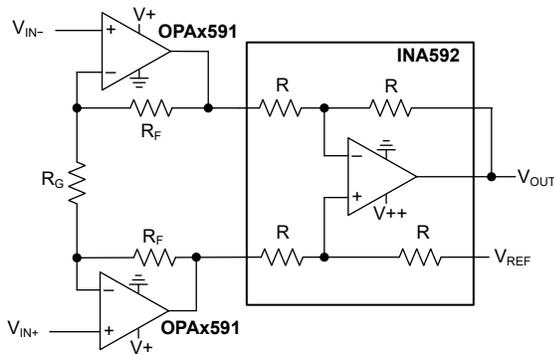
OPAx591 85V, Precision (100 μ V), Low-Power (420 μ A), High-Slew Rate (100V/ μ s) Op Amps With MUX-Friendly Inputs

1 Features

- Wide supply voltage range: 8V to 85V
- Low offset voltage: 100 μ V, max
- Low offset drift: 2 μ V/ $^{\circ}$ C, max
- High CMRR: 130dB, min
- High PSRR: 120dB, min
- Low input bias current: 15pA, max
- Low noise: 12.9nV/ $\sqrt{\text{Hz}}$ at 1kHz
- Wide bandwidth: 3.75MHz at 40dB
- High slew rate: 100V/ μ s
- Low quiescent current: 420 μ A
- Rail-to-rail output
- Unity gain stable
- Mux-friendly inputs
- Thermal shutdown protection
- Small package options:
 - Single: SOT23
 - Dual: VSSOP, SOIC

2 Applications

- [Semiconductor test](#)
- [CT & PET scanner](#)
- [Programmable DC power supply](#)
- [Source measurement unit \(SMU\)](#)
- [Analytical lab instrumentation](#)
- [Power analyzer](#)
- [Optical module](#)



OPA591 Buffer With INA592

3 Description

The OPAx591 is a family of high precision, 85V CMOS power amplifiers available in small, industry standard packages.

These devices are laser trimmed to provide excellent dc performance, including 100 μ V max offset, 2 μ V/ $^{\circ}$ C max offset drift. The high power supply and common-mode rejection help these op amps maintain high dc performance across different operating conditions. Degradation of precision is minimal because of the very low input bias current across the entire operating voltage range.

The OPAx591 also excels in ac performance despite the low quiescent current consumption. Proprietary design techniques provide 100V/ μ s slew rate and MUX-friendly inputs to enable fast settling of large signals. The low broadband noise help maintain signal fidelity across a wide frequency spectrum.

The combination of high precision, low noise, low power, and small packages make the OPAx591 a great choice for high voltage, space constrained systems where power consumption and, or thermal management is critical. Such systems include automated test equipment requiring high voltage and precision, power supplies requiring current or voltage sensing, and piezo actuator driving for haptic feedback systems.

This family of amplifiers operates over the extended industrial temperature range of -40°C to $+125^{\circ}\text{C}$.

Device Information

PART NUMBER	CHANNEL COUNT	PACKAGE (1)
OPA591(2)	Single	DBV (SOT23, 5)
OPA2591(2)	Dual	D (SOIC, 8)
		DGK (VSSOP, 8)

- (1) For all available packages, see the orderable addendum at the end of the data sheet.
- (2) This package is preview only.

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4 Pin Configuration and Functions

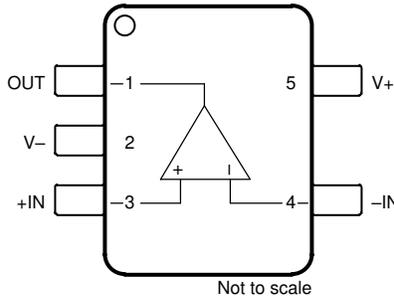


Figure 4-1. OPA591 DBV Package, 5-Pin SOT-23 (Top View)

Table 4-1. Pin Functions: OPA591

PIN		TYPE	DESCRIPTION
NAME	NO.		
+IN	3	Input	Noninverting input
-IN	4	Input	Inverting input
OUT	1	Output	Output
V+	5	Power	Positive (highest) power supply
V-	2	Power	Negative (lowest) power supply

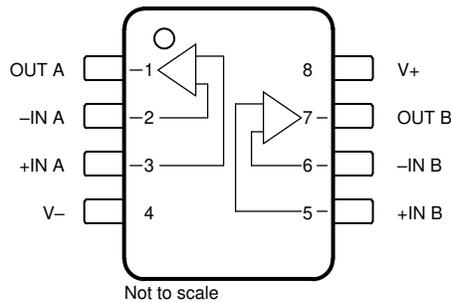


Figure 4-2. OPA2591 D Package, 8-Pin SOIC and DGK Package, 8-Pin VSSOP (Top View)

Table 4-2. Pin Functions: OPA2591

PIN		TYPE	DESCRIPTION
NAME	NO.		
+IN A	3	Input	Noninverting input, channel A
+IN B	5	Input	Noninverting input, channel B
-IN A	2	Input	Inverting input, channel A
-IN B	6	Input	Inverting input, channel B
OUT A	1	Output	Output, channel A
OUT B	7	Output	Output, channel B
V+	8	Power	Positive (highest) power supply
V-	4	Power	Negative (lowest) power supply

5 Specifications

5.1 Absolute Maximum Ratings

Over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT	
V _S	Supply voltage, V _S = (V+) – (V–)		93	V	
	Signal input pin voltage ⁽²⁾	Common-mode	(V–) – 0.3	(V+) + 0.3	V
		Differential		(V+) – (V–)	
	Input current, all input pins ⁽²⁾		±10	mA	
I _{SC}	Output short circuit ⁽³⁾		Continuous		
T _J	Junction temperature		150	°C	
T _{stg}	Storage temperature	–65	150	°C	

- (1) Operation outside the *Absolute Maximum Ratings* may cause permanent device damage. *Absolute Maximum Ratings* do not imply functional operation of the device at these or any other conditions beyond those listed under *Recommended Operating Conditions*. If used outside the *Recommended Operating Conditions* but within the *Absolute Maximum Ratings*, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.
- (2) Input terminals are diode-clamped to the power-supply rails. Input signals that can swing more than 0.3V beyond the supply rails must be current-limited to 10mA or less.
- (3) Short-circuit to ground.

5.2 ESD Ratings

			VALUE	UNIT
V _(ESD)	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±1500	V
		Charged-device model (CDM), per ANSI/ESDA/JEDEC JS-002 ⁽²⁾	±500	

- (1) JEDEC document JEP155 states that 500V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250V CDM allows safe manufacturing with a standard ESD control process.

5.3 Recommended Operating Conditions

Over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
V _S	Supply voltage	Dual supply	±4	±42.5	V
		Single supply	8	85	
T _A	Ambient temperature	–40		125	°C

5.4 Thermal Information for OPA591

THERMAL METRIC ⁽¹⁾		OPA591		UNIT
		DBV (SOT-23)		
		5 PINS		
$R_{\theta JA}$	Junction-to-ambient thermal resistance	165.4		°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	99.1		°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	64.5		°C/W
Ψ_{JT}	Junction-to-top characterization parameter	42.6		°C/W
Ψ_{JB}	Junction-to-board characterization parameter	64.2		°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A		°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

5.5 Thermal Information OPA2591

THERMAL METRIC ⁽¹⁾		OPA2591		UNIT
		D (SOIC)	DGK (VSSOP)	
		8 PINS	8 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	111.3	143.6	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	49.2	50.4	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	59.0	78.7	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	5.8	3.0	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	58.1	77.5	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	N/A	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

5.6 Electrical Characteristics

at $V_S = 85V (\pm 42.5V)$, $T_A = 25^\circ C$, $R_L = 10k\Omega$ to mid-supply, and $V_{CM} = V_{OUT} =$ mid-supply (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFFSET VOLTAGE						
V_{OS}	Input offset voltage			± 20	± 100	μV
dV_{OS}/dT	Input offset voltage drift	$T_A = -40^\circ C$ to $+125^\circ C^{(1)}$		± 0.3	± 2	$\mu V/^\circ C$
PSRR	Power supply rejection ratio	$8V \leq V_S \leq 85V$		± 0.2	± 1	$\mu V/V$
INPUT BIAS CURRENT						
I_B	Input bias current			± 5	± 15	μA
		$T_A = -40^\circ C$ to $+85^\circ C^{(1)}$			± 50	
		$T_A = -40^\circ C$ to $+125^\circ C^{(1)}$				± 1
I_{OS}	Input offset current			± 5	± 15	μA
		$T_A = -40^\circ C$ to $+85^\circ C^{(1)}$				
		$T_A = -40^\circ C$ to $+125^\circ C^{(1)}$				± 1
NOISE						
	Input voltage noise	$f = 0.1Hz$ to $10Hz$		1.4		μV_{PP}
e_n	Input voltage noise density	$f = 100Hz$		17.8		nV/\sqrt{Hz}
		$f = 1kHz$		12.9		
		$f = 10kHz$		12.8		
i_n	Current noise density	$f = 1kHz$		7		fA/\sqrt{Hz}
INPUT VOLTAGE						
V_{CM}	Common-mode voltage	Linear operation		$(V-) - 0.1$	$(V+) - 3.5$	V
CMRR	Common-mode rejection	$(V-) \leq V_{CM} \leq (V+) - 3.5V$		130	140	dB
			$T_A = -40^\circ C$ to $+125^\circ C^{(1)}$	120	140	
INPUT IMPEDANCE						
	Differential			$100 \parallel 2.5$		$M\Omega \parallel pF$
	Common-mode			$10 \parallel 5.5$		$G\Omega \parallel pF$
OPEN-LOOP GAIN						
A_{OL}	Open-loop voltage gain	$(V-) + 1V < V_O < (V+) - 1.5V$, $R_L = 10k\Omega$ to mid-supply ⁽¹⁾		134	140	dB
			$T_A = -40^\circ C$ to $+125^\circ C$	120	140	
		$(V-) + 3V < V_O < (V+) - 3.5V$, $R_L = 2k\Omega$ to mid-supply		116	126	
			$T_A = -40^\circ C$ to $+125^\circ C^{(1)}$	116	126	
FREQUENCY RESPONSE						
GBW	Gain-bandwidth product	$G = 1$		2.25		MHz
		$G = 10$		3		
		$G = 100$		3.75		
SR	Slew rate	$G = \pm 1$, $V_O = 70V$ step		100		$V/\mu s$
t_s	Settling time	$T_o \pm 0.01\%$, $G = 1$, $V_O = 70V$ step, $C_L = 20pF$		3		μs
	Overload recovery	$G = -10$		115		ns
THD+N	Total harmonic distortion + noise	$G = +1$, $V_O = 70V_{PP}$, $f = 1kHz$	$R_L = 10k\Omega$		-102	dB
			$R_L = 2k\Omega$		-95	

5.6 Electrical Characteristics (continued)

at $V_S = 85V (\pm 42.5V)$, $T_A = 25^\circ C$, $R_L = 10k\Omega$ to mid-supply, and $V_{CM} = V_{OUT} = \text{mid-supply}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
OUTPUT						
V_O	Voltage output swing from rail ⁽¹⁾	No load		12	50	mV
		$R_L = 10k\Omega$ to mid-supply		100	500	
		$R_L = 2k\Omega$ to mid-supply		500	2.5	V
I_{SC}	Output current		± 30			mA
C_{LOAD}	Capacitive load drive			1		nF
Z_O	Open-loop output impedance	$f = 1\text{MHz}$		550		Ω
POWER SUPPLY						
I_Q	Quiescent current	$I_O = 0\text{mA}$		420	490	μA
			$T_A = -40^\circ C$ to $+125^\circ C$ ⁽¹⁾			
TEMPERATURE						
	Overtemperature shutdown	Shutdown temperature, T_J		170		$^\circ C$
		Thermal hysteresis		20		

(1) Specification established from device population bench system measurements across multiple lots.

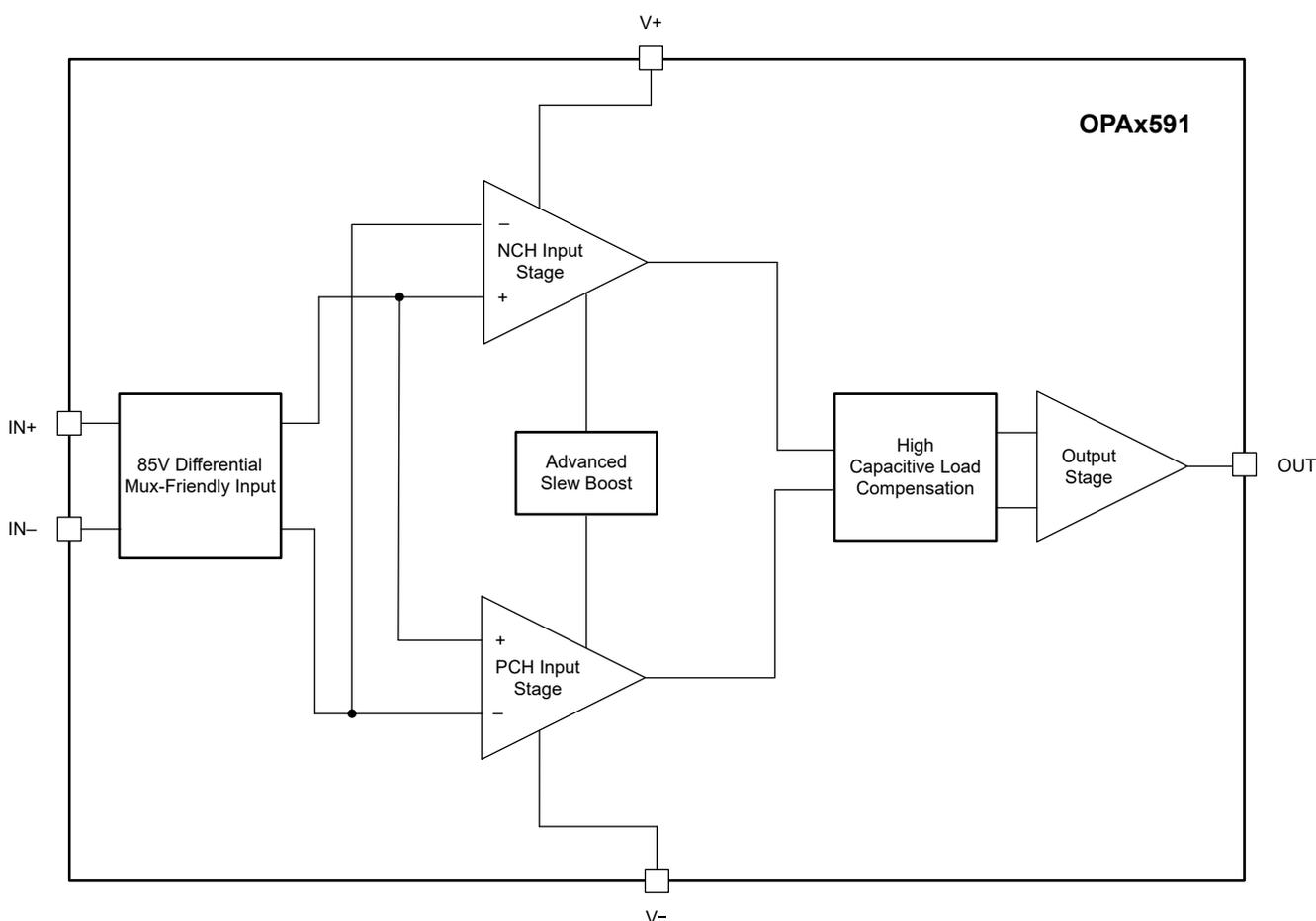
6 Detailed Description

6.1 Overview

The OPAx591 are high precision, low power (420 μ A), high-slew rate (100V/ μ s), 85V operational amplifiers (op amps). These op amps use a proprietary design technique to achieve a very high slew capability with minimal power consumption. The OPAx591 is capable of driving \pm 30mA of output current and can swing to within 100mV of either power supply rail.

The amplifiers feature state-of-the-art CMOS technology and advanced design features that help achieve outstanding ac performance and enable small package options. The OPAx591 strengths also include 3.75MHz bandwidth, 12.8nV/ \sqrt Hz noise spectral density, and low input bias current. These features make the OPAx591 an exceptional choice to gain or buffer the output of a digital-to-analog converter (DAC) and precision high-side current sense applications.

6.2 Functional Block Diagram



6.3 Feature Description

6.3.1 MUX-Friendly Inputs

The OPAx591 use a unique input architecture to eliminate the need for input protection diodes but still provide robust input protection under transient conditions. The conventional input diode protection schemes in [Figure 6-1](#) are activated by fast transient step responses, and potentially introduce signal distortion and settling time delays because of alternate current paths; see also [Figure 6-2](#). For low-gain circuits, these fast-ramping input signals forward-bias back-to-back diodes that cause an increase in input current and result in extended settling time.

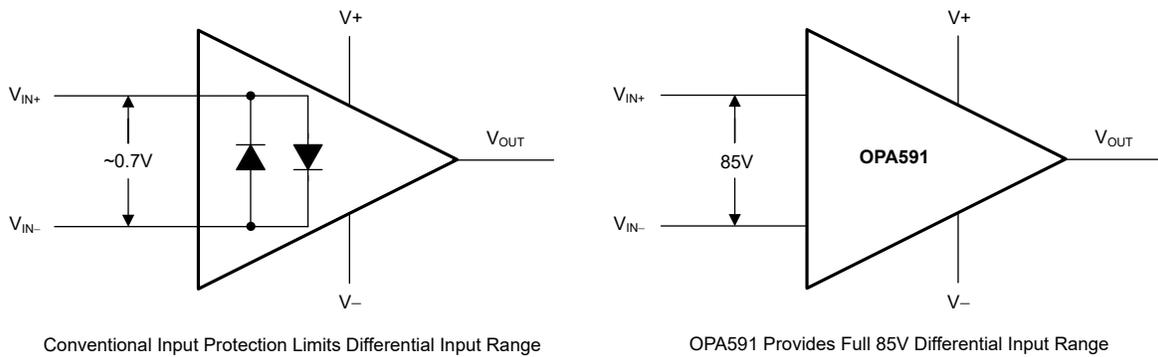


Figure 6-1. OPA591 Input Protection Does Not Limit Differential Input Capability

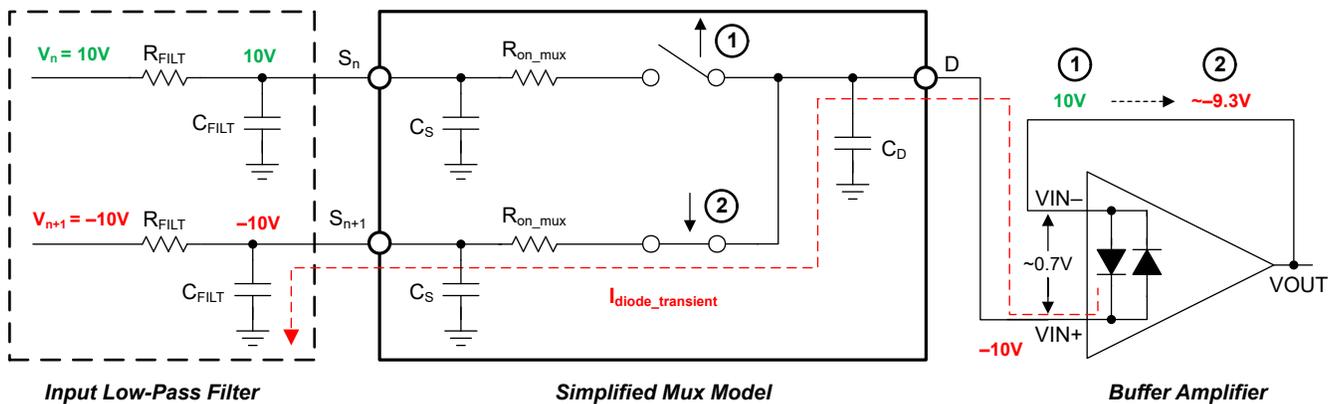


Figure 6-2. Back-to-Back Diodes Create Settling Issues

The OPAx591 feature a true high-impedance differential input capability for high-voltage applications. This patented input protection architecture does not introduce additional signal distortion or delayed settling time, making these devices an excellent choice for multichannel, high-switched, input applications. The OPAx591 tolerate a maximum differential swing (voltage between inverting and noninverting pins of the op amp) of up to 85V, making these devices a great choice for use as a comparator or in applications with fast-ramping or switched input signals.

6.3.2 Thermal Protection

The OPAx591 has a thermal protection feature that prevents damage from self heating. When the junction temperature (T_J) reaches approximately 170°C, the op amp output stage disables. This thermal protection works by monitoring the temperature of the output stage and turning off the op amp output drive. Thermal protection forces the output to a high-impedance state. The OPAx591 is designed with approximately 20°C of thermal hysteresis and returns to normal operation when the output stage temperature becomes less than approximately 150°C.

This thermal protection is not designed to prevent this device from exceeding absolute maximum ratings, but rather from excessive thermal overload.

6.3.3 Advanced Slew Boost

Slew rate is the maximum rate of change of output voltage change with respect to time and is typically specified in units of volts per microsecond, V/μs. Op amps can enter a slew condition when a large, rapid moving signal is applied at the input. While slewing, the op amp enters an open loop condition and significant slew induced distortion can be seen on the output signal.

Equation 1 shows that the slew rate, SR, of an op amp is typically determined by the saturation current of the input stage, I_{TAIL} , and the compensation capacitor, C_C .

$$SR = \frac{I_{TAIL}}{C_C} \quad (1)$$

Slew rate typically scales with the quiescent current, I_Q , of the op amp. There are several ways that designers have overcome slew rate limitation. For example, lowering C_C , commonly known as decompensation, improves slew rate at the expense of stability. Decompensated op amps require a minimum gain and are not stable at unity gain. More commonly, modern op amps are equipped with slew boost technology that increases I_{SAT} to improve slew rate. Slew boost circuits can vary in implementation, but typically, expect about a four-fold improvement over comparable unboosted op amps.

The OPAx591 uses a proprietary design to achieve an unprecedented slew rate to I_Q ratio. The novel slew boost technology in OPAx591 provides a nearly 100 × slew rate improvement over comparable unboosted op amps. The op amp is unity gain stable and can be used configured as a buffer if desired.

Table 6-1 shows a comparison of slew rates and quiescent currents of different op amps.

Table 6-1. Op Amp Slew Rates and Quiescent Current

PART NUMBER	SLEW RATE	QUIESCENT CURRENT
OPA591	100V/μs	420μA
OPA188	0.8V/μs	425μA
OPA202	0.35V/μs	580μA
OPA192	20V/μs	1mA
OPA454	13V/μs	3.2mA

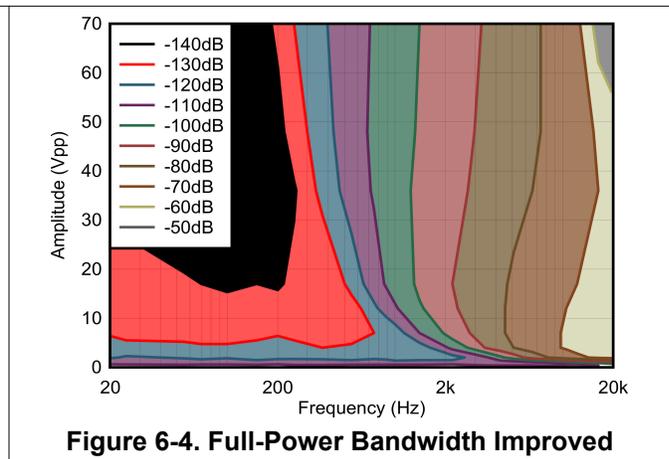
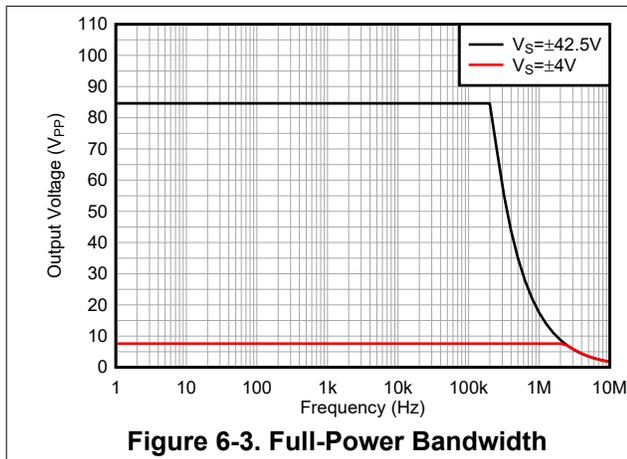
6.3.4 Full-Power Bandwidth Improved

The full-power bandwidth curve has been a staple in data sheets for decades. The full-power bandwidth of an op amp provides some indication about where designers can expect slew-induced distortion on a signal of a given amplitude and frequency. The full-power bandwidth curve is generated using Equation 2.

$$FPBW = \frac{SR}{2\pi V_{OUT_MAX}} \quad (2)$$

Figure 6-3 shows the full-power bandwidth of the OPAx591. The curve is a good reference for designers that need to achieve high-voltage, high-frequency output swings with little concern for distortion performance. Unfortunately, the curve provides little indication of the true distortion at any given point on the curve. The full-power bandwidth curve is, after all, only a theoretical value and slew-induced distortion appears gradually as the output nears the maximum rate of change. Furthermore, slew-induced distortion is only one of several sources of op-amp distortion. Therefore, the curve is a decent starting point, but not a reliable source for distortion performance.

Figure 6-4 shows the full power bandwidth in terms of total harmonic distortion (THD) performance for the OPAx591. This curve provides a better indication of the level of distortion that a designer can expect for a signal of a given amplitude and frequency. For example, the OPAx591 can achieve approximately -100dB or better of THD at 70V_{PP} up to approximately 1kHz. As a second example, the OPAx591 can achieve approximately -130dB or better of THD at 10V_{PP} up to about 1kHz. As a result of limitations in measurement bandwidth, only 20kHz data are recorded.



6.3.5 Overload Recovery

Overload recovery is defined as the time required for the op amp output to recover from a saturated state to a linear state. The output devices of the op amp enter a saturation region when the output voltage exceeds the rated operating voltage, either due to the high input voltage or the high gain. After the device enters the saturation region, the charge carriers in the output devices require time to return back to the linear state. After the charge carriers return back to the linear state, the device begins to slew at the specified slew rate. Thus, the propagation delay in case of an overload condition is the sum of the overload recovery time and the slew time.

6.4 Device Functional Modes

The OPAx591 has a single functional mode and is operational when the power-supply voltage is between 8V (±4V) and 85V (±42.5V).

7 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

7.1 Application Information

The OPAx591 are high precision, low power (420µA), high-slew rate (100V/µs), 85V power operational amplifiers (op amps). These op amps use a proprietary design technique to achieve a very high slewing capability while consuming minimal power. The low power consumption helps reduce heat generation on the board while the output swings near the supply rail. The high slew reduces slew related distortion at the output when dealing with large peak, high frequency signals.

7.2 Typical Applications

7.2.1 High Voltage Instrumentation Amplifier

Current monitoring is a critical function in a wide range of applications. While several current sensing methods exist, a shunt resistor provides a highly accurate, and robust approach. Designers need to choose between high-side and low-side current measurements. High-side measurement is often preferred where accuracy and load protection are critical.

High-side current sense circuits require special consideration of the input and output common-mode limitations of the amplifier. The biggest challenge in high-side current measurements is making sure that the amplifier can support and mitigate the errors that are inherent to high common-mode voltage. Designers can attenuate the common-mode voltage by using a difference amplifier, but significant gain and input impedance trade-offs exist. High input impedance and large gain is especially critical when measuring small currents. In such cases, an instrumentation amplifier provides the required input impedance, and gain.

The trade-off is that instrumentation amplifiers have a complex input voltage range that depends on the common-mode voltage, differential voltage, gain, and reference voltage. The input stage alone is bound by the input common-mode voltage limitation and the maximum power supply voltage range of the operational amplifier. Fortunately, the OPAx591 offers a high operating power supply voltage that enables designers to build a very high common-mode, high impedance, high gain, high common-mode rejection instrumentation amplifier. This instrumentation amplifier can be used to measure small differential signals in the presence of very high common-mode voltage.

7.2.1.1 Design Requirements

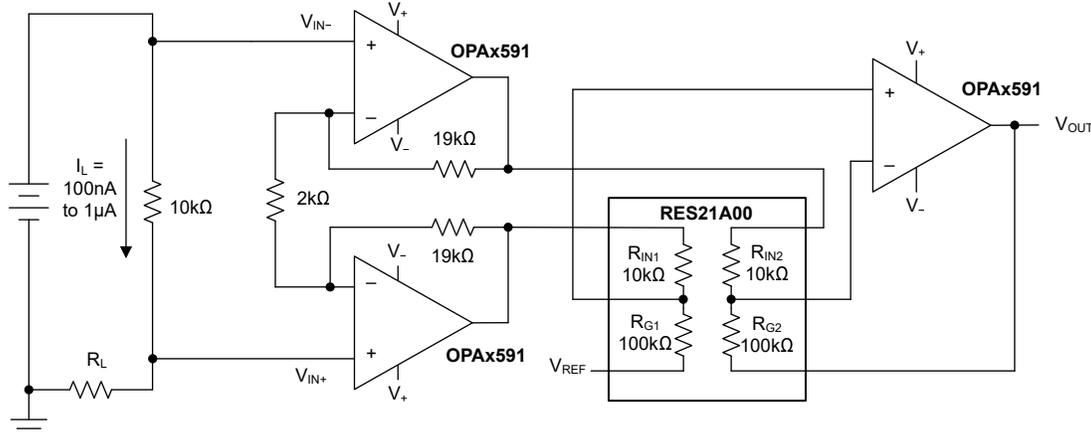


Figure 7-1. OPAx591 Instrumentation Amplifier With RES31A

The OPAx591 is used to build a high precision instrumentation amplifier that is capable of operating with high common-mode voltages. This instrumentation is an attractive option for high voltage, high-side current sensing. A high-voltage, high-side current sense application is discussed here.

Use the following parameters for this design example:

- Common-mode voltage: 54V
- Current output range: 100nA to 1μA
- Typical uncalibrated error: < 0.1%

7.2.1.2 Detailed Design Procedure

The OPAx591 can be configured as a three operational amplifier (op amp) to achieve a very high input common-mode voltage range. The instrumentation amplifier can be compartmentalized as a two stage amplifier with an input or gain stage, and a difference amplifier stage. [Figure 7-2](#) illustrates a generic three op amp instrumentation amplifier.

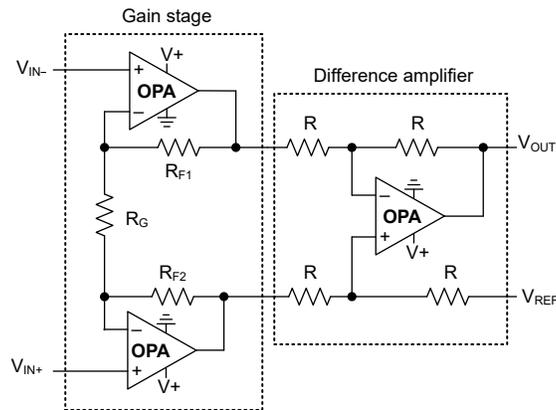


Figure 7-2. Instrumentation Amplifier

To support the high common-mode voltage range requirement, the OPAx591 is powered with 85V, yielding a 81.5V input common-mode voltage. The OPAx591 has an input voltage range of (V-) - 0.1V to (V+) - 3.5V. The output voltage swing also limits the common-mode voltage for a given differential voltage. The relationship is given below in [Equation 3](#). Note that 85V is the maximum operating power supply voltage of the OPAx591 and the 1.5V accounts for the linear output voltage swing for 10kΩ as given in *Electrical Characteristics*.

$$V_{IN+} + (V_{IN+} - V_{IN-}) \left(\frac{R_F}{R_G} \right) < 85V - 1.5V \quad (3)$$

The shunt resistor is set to be as small as possible to minimize the voltage drop. Given practical amplifier error sources, choose a shunt resistor that provides a voltage drop large enough to meet the accuracy requirements of the application. The largest error source in current sense applications is the amplifier and resistor drift and typically set the lower bound on the shunt resistor value. In most general purpose applications, a voltage drop of no more than 100mV is acceptable.

The OPAx591 provides very low offset and offset drift to enable high accuracy measurements to be made even at low current values. Another benefit of the OPAx591 is the low input bias current of 15pA, maximum. The low input bias current enables high accuracy measurements down to the nanoampere range.

OPAx591 circuit is configured to provide a maximum output voltage of 20V for a full scale current of 1μA, corresponding to a 100mV drop across the 10kΩ shunt resistor. The gain of the first stage is set to 20V/V and the difference amplifier stage gain is set to 10V/V for a total gain of 200V/V. The lower bound of the current measurement capability of the circuit is determined by the maximum error tolerance of the application such that the percent error of the circuit increases as the voltage drop across the shunt resistor decreases. The transfer function of the amplifier given by [Equation 4](#).

$$V_{OUT} = (V_{IN+} - V_{IN-}) \left(1 + \frac{2R_F}{R_G} \right) \left(\frac{R_{G2}}{R_{IN2}} \right) + V_{REF} \quad (4)$$

This application uses the [RES31A](#) matched resistor chip from Texas Instruments. The resistors provide excellent matching and temperature drift when compared to discrete 0.1% resistors. Resistor matching is critical to achieving high common-mode rejection and low gain error. [Figure 7-1](#) shows the final circuit. The circuit results are shown in [Figure 7-4](#), [Figure 7-5](#). Note that the error is a simulated result at room temperature with typical dc error values and worst case resistor matching values. Room temperature calibration is recommended to achieve higher accuracy measurements.

To simplify this circuit further, the OPAx591 can be used to gain and buffer a readily available monolithic difference amplifier, like INA132. The OPAx591 provide high gain and high input impedance necessary to measure small current values.

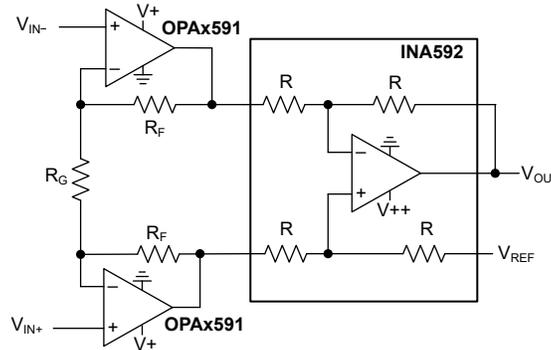


Figure 7-3. OPA591 Buffer for INA132

7.2.1.3 Application Curves

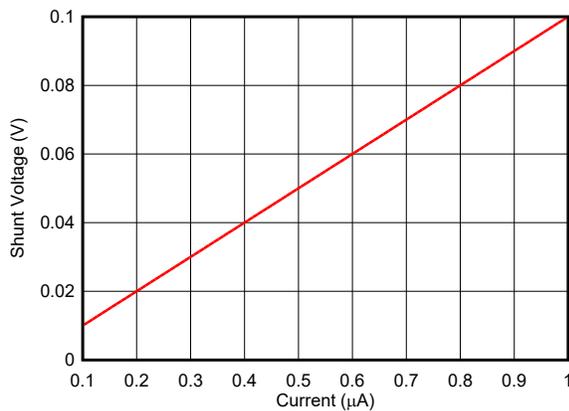


Figure 7-4. Voltage Across Shunt Resistor

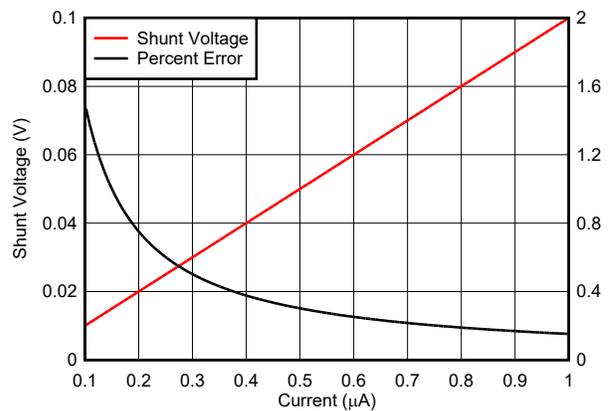
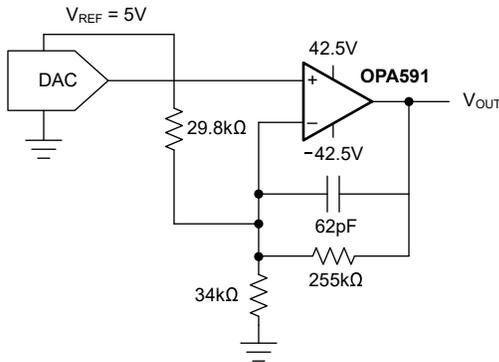


Figure 7-5. Output Voltage and Error

7.2.2 DAC Output Gain and Buffer

Many applications require precise control of a high voltage signal, but existing digital-to-analog converters (DACs) have a limited output range of 0V to 5V. The OPAx591 is designed for use as an output driver stage with gain to provide a high voltage, bipolar output voltage. The OPAx591 offers excellent dc precision at high voltage, small form factor packages, and low power consumption, making these amplifiers a great choice for high-channel, high density systems common in many test and measurement applications.

V_{OUT}



7.2.3 Single-Supply Piezoelectric Driver

Some piezoelectric transducers can be referenced to ground as shown in Figure 7-6. The piezoelectric load presents a large capacitance at the output of the amplifier and proper compensation is required to avoid instability. Figure 7-6 uses a dual-feedback compensation scheme to improve phase margin and enable accurate voltage setting to the load. Also consider the output current drive requirement. The current drive demand is determined by the frequency of operation and the effective capacitance of the load. High frequency and large capacitance reduce the effective impedance of the load and thereby increase the current drive requirement. The OPAx591 are an excellent choice to drive piezoelectric loads at dc and low frequency.

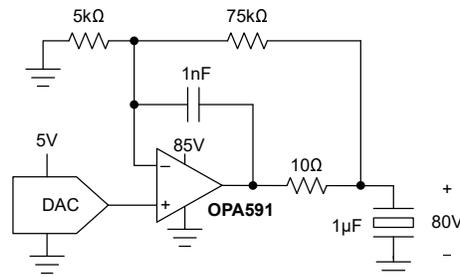


Figure 7-6. 80V Single-Supply Piezoelectric Driver

7.2.4 Current Booster

Some instances exist where designers require more output current drive from the OPAx591. Fig shows a simple current booster circuit that enables high voltage, high current drive capability. The circuit can be built with a couple of power MOSFETs or BJTs. One advantage of this circuit over monolithic power amplifiers is the significantly better thermal performance. The external transistors deliver the power and the OPAx591 is kept relatively cool to prevent any thermally related performance degradation.

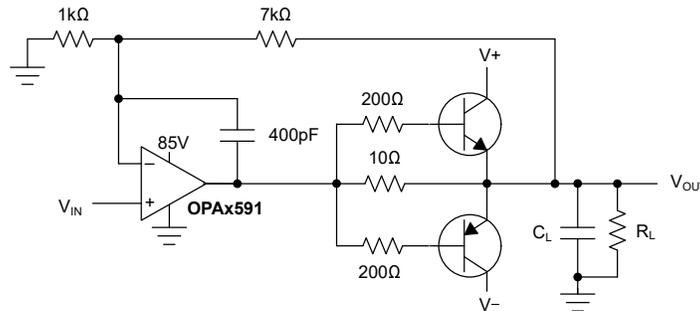


Figure 7-7. Current Booster Circuit

7.3 Creepage and Clearance

When designing and building electrical systems with high voltage, two important concepts to consider are creepage and clearance. Creepage distance refers to the shortest path that an electric current can take along the surface of an insulating material, such as a printed circuit board (PCB) or a plastic enclosure. Clearance distance refers to the shortest distance between two conductive parts, such as wires, terminals, or components, through the air. Figure 7-8 illustrates creepage and clearance for a typical integrated circuit (IC).

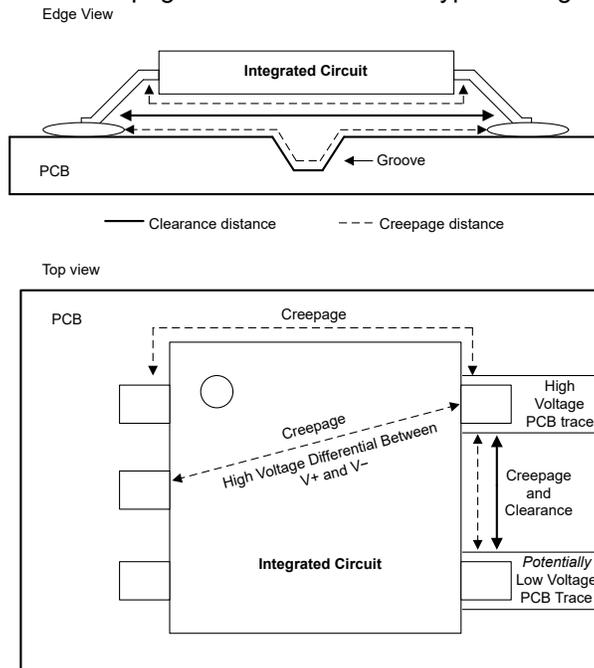


Figure 7-8. Creepage and Clearance in Integrated Circuits

Several standards exist with creepage and clearance guidance, but how the standards pertain to operational amplifiers and other integrated circuits is largely left to interpretation and internal requirements. The guidance distances are significantly affected by pollution degree, maximum voltage, and the underlying application. In the case of creepage, the comparative tracking index (CTI) rating of the insulating material is a major factor.

Different design techniques exist to improve creepage and clearance if deemed necessary, including adding PBC grooves, conformal coating, and, or derating the operating voltage.

Texas Instruments offers modern packaging with small dimensions that are designed to minimize PCB area. However, the requirement to meet any creepage or clearance specifications depends on the designer's interpretation and implementation of any relevant IEC or system-level standards. For more information on this topic, visit the [Demystifying Clearance and Creepage Distance for High-Voltage End Equipment](#) document.

7.4 Power Supply Recommendations

The OPAX591 operates from power supplies up to $\pm 42.5\text{V}$ (85V), and as little as $\pm 4\text{V}$ (8V) with excellent performance. Most behavior remains unchanged throughout the full operating voltage range, but parameters can vary with operating voltage. A power-supply bypass capacitor of at least $0.1\mu\text{F}$ is required for proper operation. Make sure that the capacitor voltage is rated for high voltage across the full operating temperature range. The OPAX591 can be powered with asymmetrical supplies to optimize power dissipation in applications that do not require an equal positive and negative output voltage swing.

7.5 Layout

7.5.1 Layout Guidelines

For best operational performance of the device, use good printed circuit board (PCB) layout practices, including the following guidelines:

- Noise can propagate into analog circuitry through the power pins of the op amp and the circuit as a whole. Connect low-ESR, $0.1\mu\text{F}$ ceramic bypass capacitors between each supply pin and ground. Place the capacitors as close to the device as possible. A single bypass capacitor from $V+$ to ground is sufficient for single supply applications.
- Separate grounding for analog and digital portions of circuitry is one of the simplest and most effective methods of noise suppression. One or more layers on multilayer PCBs are typically devoted to ground planes. A ground plane helps distribute heat and reduces EMI noise pickup. Physically separate digital and analog grounds paying attention to the flow of the ground current.
- To reduce parasitic coupling, run the input traces as far away from the supply or output traces as possible. If these traces cannot be kept separate, crossing the sensitive trace perpendicular is much better as opposed to in parallel with the noisy trace.
- Place the external components as close to the device as possible.
- Keep the length of input traces as short as possible. Always remember that the input traces are the most sensitive part of the circuit.
- Consider a driven, low-impedance guard ring around the critical traces. A guard ring can significantly reduce leakage currents from nearby traces that are at different potentials.
- Clean the PCB following board assembly for best performance.
- Any precision integrated circuit can experience performance shifts due to moisture ingress into the plastic package. Following any aqueous PCB cleaning process, bake the PCB assembly to remove moisture introduced into the device packaging during the cleaning process. A low temperature, post cleaning bake at 85°C for 30 minutes is sufficient for most circumstances.

7.5.1.1 Thermal Considerations

Through normal operation, the op amps can self-heat. Self-heating is a natural increase in the die junction temperature that occurs in every amplifier. This self-heating is a result of several factors, including quiescent power consumption, package thermal resistance, PCB layout, and device operating conditions.

Operate the OPAX591 within the rated junction temperature, T_J , range to avoid thermal shutdown. Use the [Equation 5](#) to determine the estimated T_J

$$T_J = P_D \times R_{\theta JA} + T_A \quad (5)$$

In a quiescent state, P_D is given by the product of the power supply and the quiescent current of the op amp. Equation 6 shows the calculation of T_J for the OPAx591 assuming an 85V power supply is used and an operating temperature of 25°C.

$$T_J = (85V \times 490\mu A) \times 165.4 \frac{^\circ C}{W} + 25^\circ C \quad (6)$$

$$T_J = 31.89^\circ C \quad (7)$$

The low power consumption of the OPAx591 causes minimal self-heating even in a small SOT23-5 package as given by Equation 7. In a loaded condition, P_D is equal to addition of the quiescent power, P_{DQ} and the power dissipated by the output stage, P_{DL} . The worst-case condition is given when the output voltage is equal to ½ of either supply rail (assuming symmetrical supplies, V+ and V-). In a worst-case condition, P_{DL} is given by Equation 8.

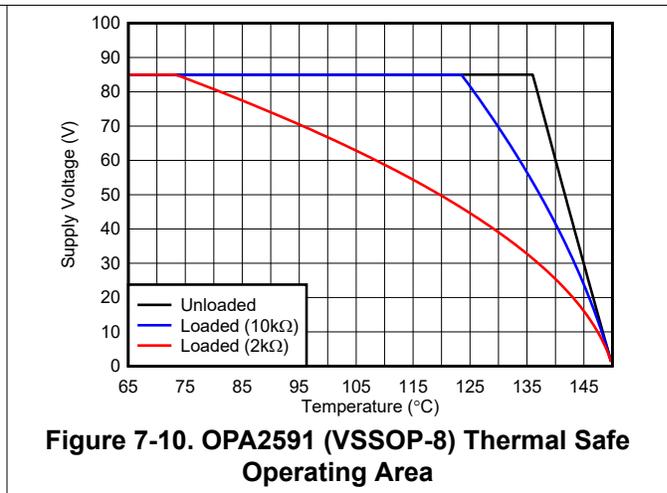
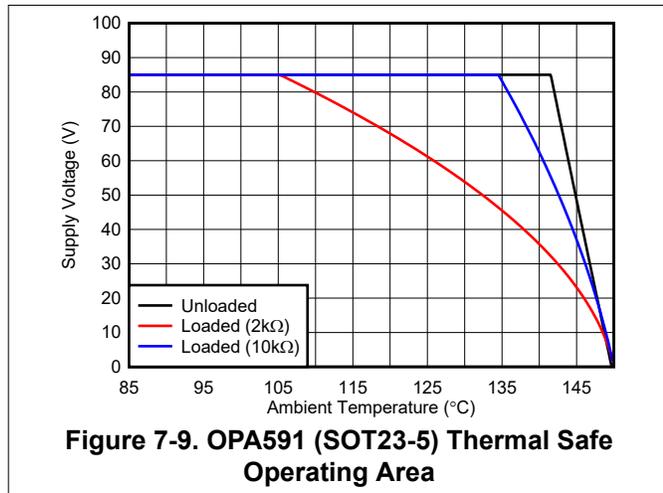
$$P_{DL} = \frac{(V+)^2}{4 \times R_L} \quad (8)$$

For example, assume the OPAx591 is powered with bipolar ±42.5V power supplies and drives a 5kΩ load, R_L , to ground. The maximum increase in T_J is expected to be about 22°C as given by Equation 9. In this example, to keep the op amp within the *Absolute Maximum Ratings*, operate in T_A well under 128°C to account for different factors. The calculation for a 5kΩ load is depicted visually in Figure 7-9.

$$\Delta T_J = (41.7mW + 90.3mW) \times 165.4 \frac{^\circ C}{W} \quad (9)$$

For high-voltage amplifiers such as the OPAx591, the junction temperature can easily be tens of degrees higher than the ambient temperature in a quiescent (unloaded) condition. As shown by Equation 5, the junction temperature depends on the thermal properties of the package, as expressed by the junction-to-ambient thermal resistance ($R_{\theta JA}$). If the device then begins to drive a heavy load, the junction temperature can rise and trip the thermal-shutdown circuit. Figure 7-9 shows the maximum output voltage versus ambient temperature to avoid exceeding the *Absolute Maximum Ratings* in both loaded and unloaded conditions for the SOT23-5 package version of the OPA591. The curve assumes a typical quiescent current and does not account for any temperature variation of quiescent current.

ADVANCE INFORMATION



7.5.2 Layout Example

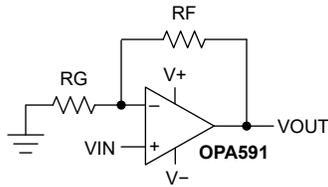


Figure 7-11. Schematic Representation of Noninverting Configuration

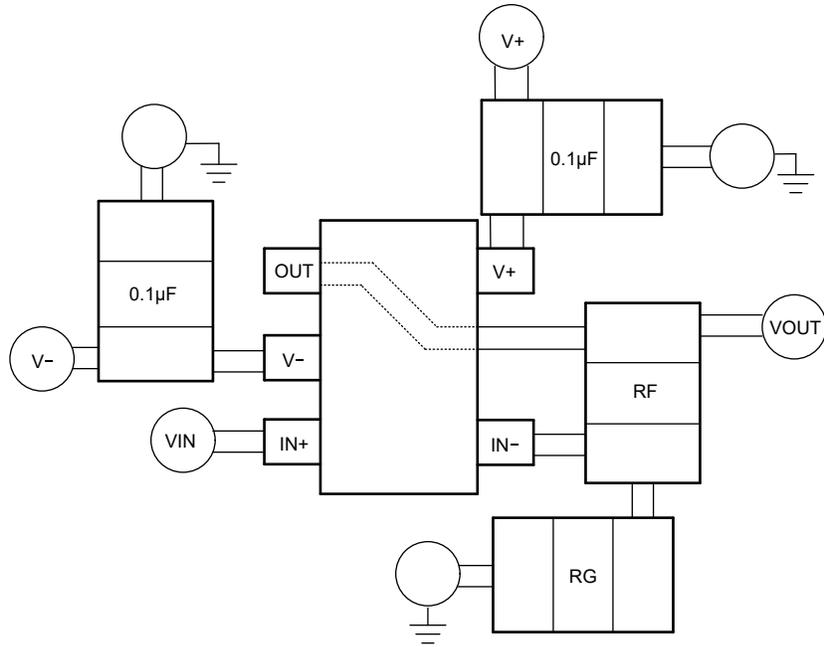


Figure 7-12. Board Layout for Noninverting Configuration of the SOT23-5 Package

ADVANCE INFORMATION

8 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

8.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

8.2 Support Resources

TI E2E™ [support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

8.3 Trademarks

TI E2E™ is a trademark of Texas Instruments.
All trademarks are the property of their respective owners.

8.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

8.5 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

9 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
POPA2591DGKR	Active	Preproduction	VSSOP (DGK) 8	2500 LARGE T&R	-	Call TI	Call TI	-40 to 125	
POPA591DBVR	Active	Preproduction	SOT-23 (DBV) 5	3000 LARGE T&R	-	Call TI	Call TI	-40 to 125	

(1) **Status:** For more details on status, see our [product life cycle](#).

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

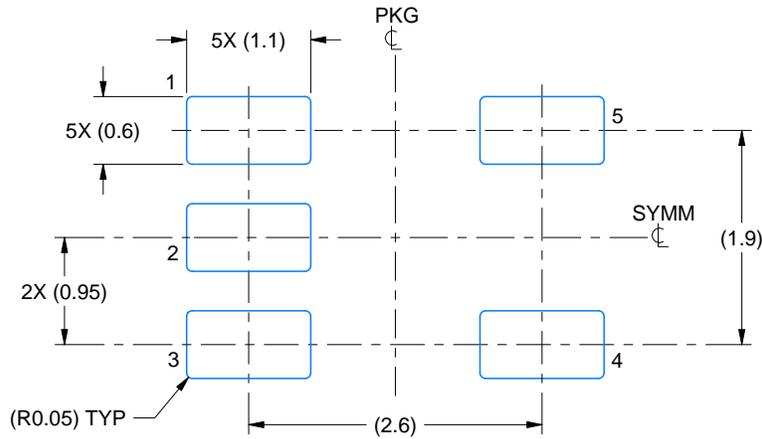
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

EXAMPLE BOARD LAYOUT

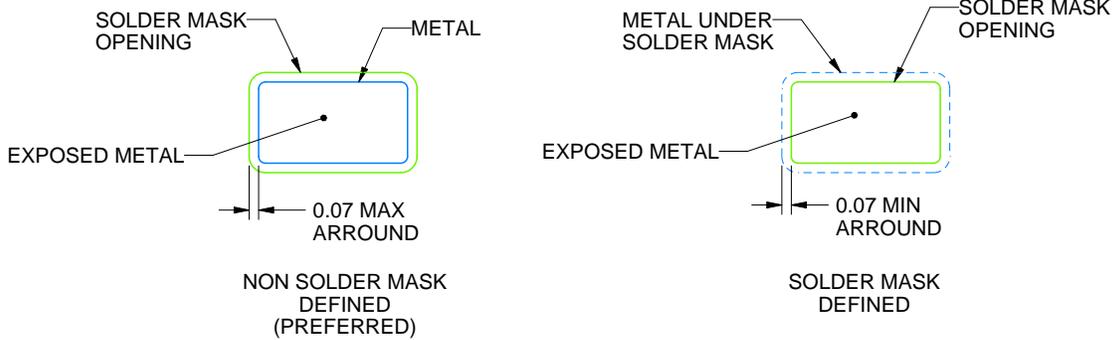
DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:15X



SOLDER MASK DETAILS

4214839/K 08/2024

NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:15X

4214839/K 08/2024

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

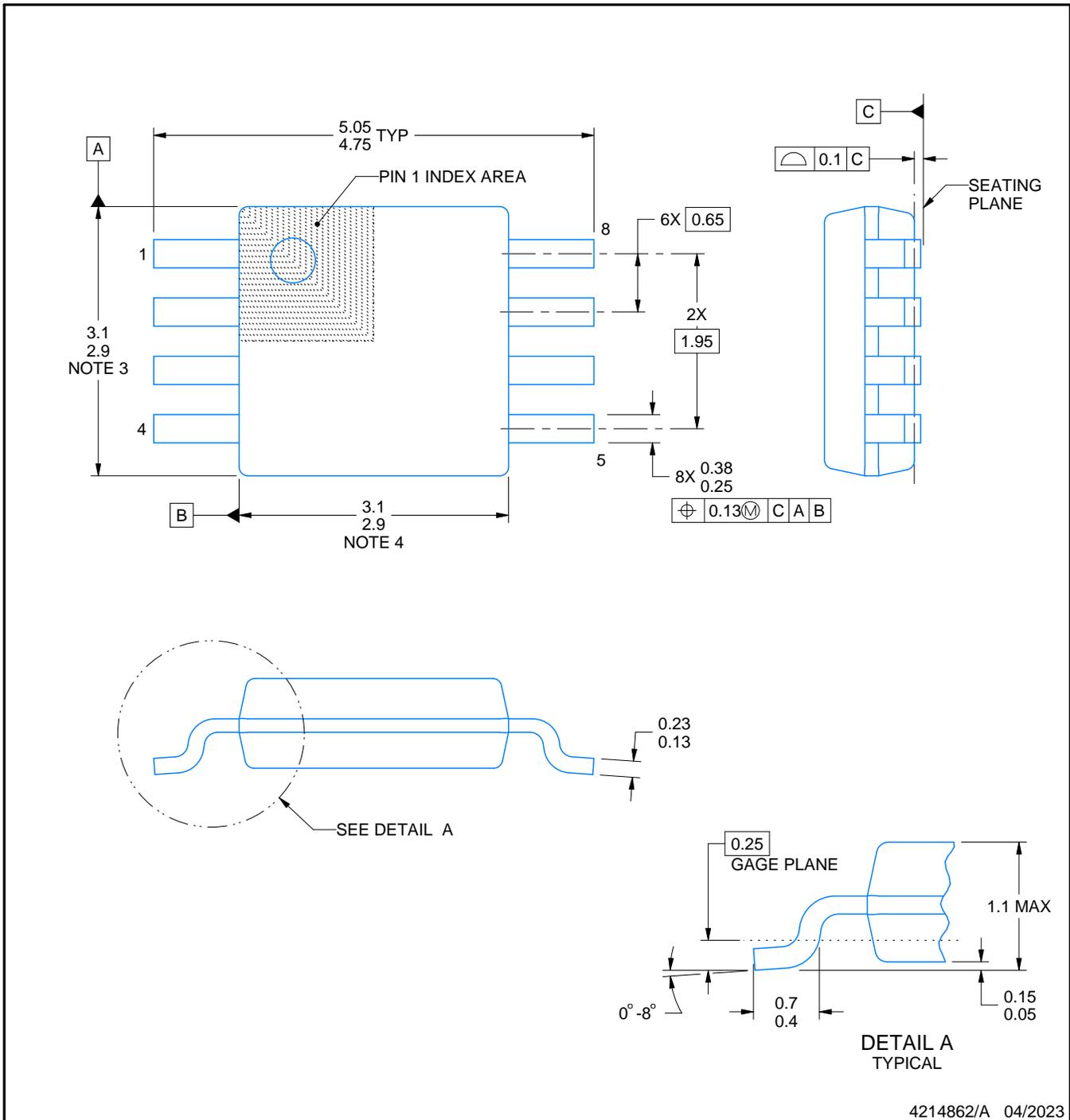
DGK0008A



PACKAGE OUTLINE

VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



NOTES:

PowerPAD is a trademark of Texas Instruments.

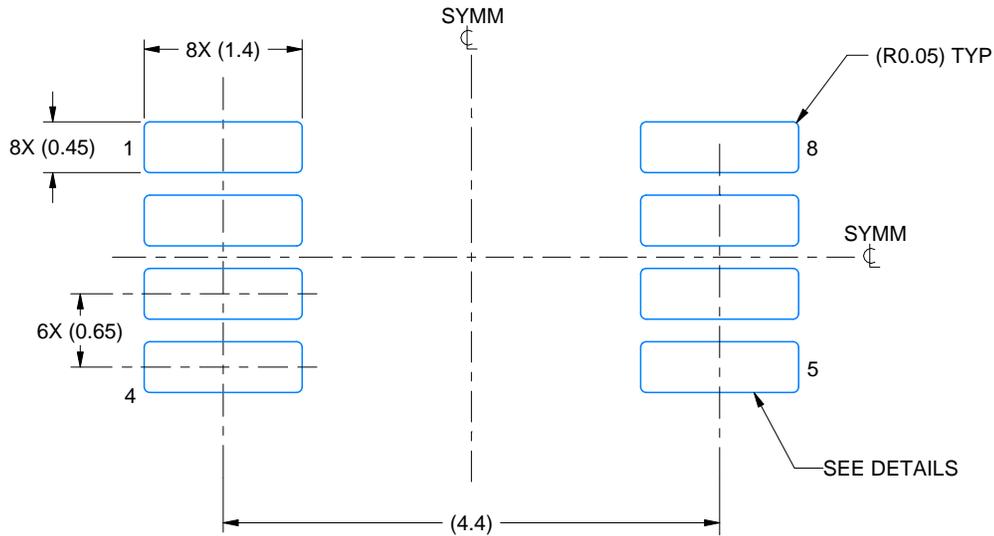
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-187.

EXAMPLE BOARD LAYOUT

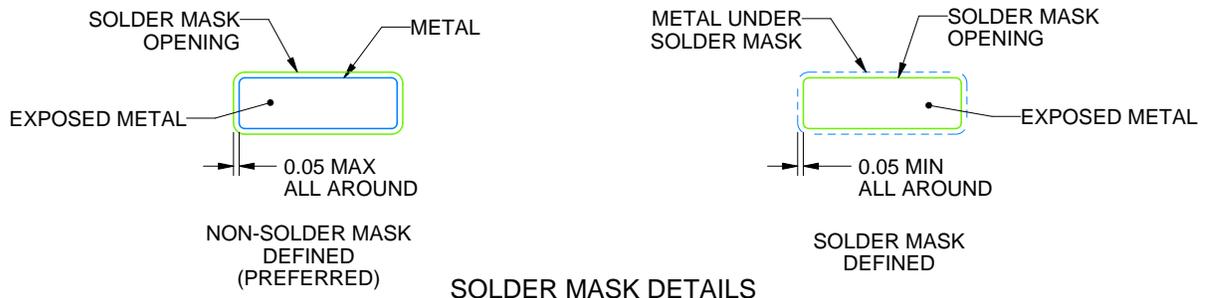
DGK0008A

™ VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 15X



SOLDER MASK DETAILS

4214862/A 04/2023

NOTES: (continued)

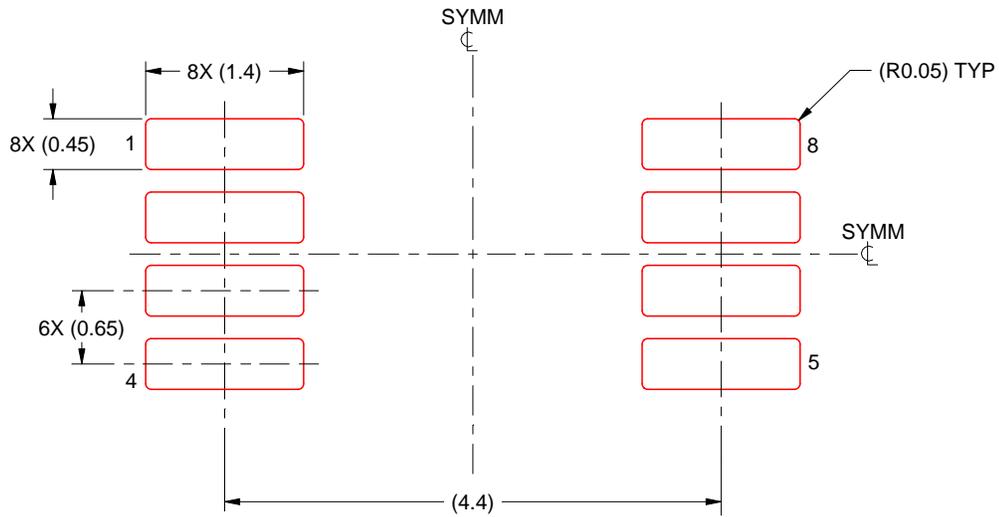
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
9. Size of metal pad may vary due to creepage requirement.

EXAMPLE STENCIL DESIGN

DGK0008A

TM VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
SCALE: 15X

4214862/A 04/2023

NOTES: (continued)

11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
12. Board assembly site may have different recommendations for stencil design.

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